

DE 3 - 30741

IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST CERTIFICATES FOR ELECTRICAL EQUIPMENT (IECEE) CB SCHEME

SYSTEME CEI D'ACCEPTATION MUTUELLE DE CERTIFICATS D'ESSAIS DES EQUIPEMENTS ELECTRIQUES (IECEE) METHODE OC

CB TEST CERTIFICATE CERTIFICAT D'ESSAI OC

Product

Laboratory Equipment

(Microscope)

Name and address of the applicant

Leica Microsystems CMS GmbH

Ernst-Leitz-Straße 17-37 35578 Wetzlar, GERMANY

Name and address of the manufacturer

Leica Microsystems Ltd. Shanghai

Building 1, 258 Jinzang Road, China (Shanghai) Pilot Free Trade,

201206 Shanghai, PEOPLE'S REPUBLIC OF CHINA

Name and address of the factory

Leica Microsystems Ltd. Shanghai

Building 1, 258 Jinzang Road, China (Shanghai) Pilot Free Trade,

201206 Shanghai, PEOPLE'S REPUBLIC OF CHINA

Ratings and principal characteristics

Microscope:

12V

Rated voltage: Rated frequency:

DC

Rated input power:

18W

Protection class:

Ш

Lamp classification:

Exempt group

Trade mark (if any)

Leica

Model/type Ref.

DM1000 LED

Additional information (if necessary)

Certificate DE 3 - 3630 issued 2013-02-06 is replaced by this

version due to technical changes

A sample of the product was tested and found

to be in conformity with

IEC 61010-1:2010 IEC 61010-2-101:2015

as shown in the Test Report Ref. No. which forms part of this certificate

028-713135642-000

This CB Test Certificate is issued by the National Certification Body Ce Certificat d'essai OC est établi par l'Organisme **National de Certification**

Date,

2018-06-26

CB 18 06 56257 189

Kisely

Ralph Fischer

TÜV SÜD Product Service GmbH · Certification Body · Ridlerstrasse 65 · D-80339 München



Product Service